

Substitute Form PTO-1449

U.S. Department of Commerce  
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Attorney's Docket No.  
07927-033001

Application No.  
09/928,914

**Information Disclosure Statement  
by Applicant**

(Use several sheets if necessary)

(37 CFR 1.98(b))

Applicant  
Kalnitsky et al.

Filing Date  
August 13, 2001

Group Art Unit  
Unknown

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
AK	AA	4,301,588	11/24/81	Hornig et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						

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**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes	Translation No
	AI							
	AJ							
	AK							
	AL							
	AM							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
AK	AN	Ashburn, "Polysilicon Emitter Technology," <u>Proceedings of the 1989 Bipolar Circuits and Technology Meeting</u> , Minneapolis Marriott City Center Hotel, September 18-19, 1989, Sponsored by IEEE Electron Devices Society, pp. 90-97
AK	AO	Burghartz et al., "Perimeter and Plug Effects in Deep Sub-Micron Polysilicon Emitter Bipolar Transistors," 1990 Symposium on VLSI Technology - Digest of Technical Papers, 1990, pp. 55-56
AK	AP	Decoutere et al., "A Unified Approach for Hot-Carrier Degradation of Current Gain and 1/f Noise of Polysilicon Emitter Bipolar Transistors," <u>Proceedings of the 1997 Bipolar/BiCMOS Circuits and Technology Meeting</u> , September 28-30, 1997, Sponsored by IEEE Electron Devices Society, pp. 104-107
AK	AQ	Reuss et al., "Effects of Interfacial Oxide on Hot Carrier Reliability of Polysilicon Emitter npn Transistors," <u>Proceedings of the 1993 Bipolar/BiCMOS Circuits and Technology Meeting</u> , 1993, Sponsored by IEEE Electron Devices Society, pp. 219-222

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Disclosure Form (PTO-1449)

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